

# (Machine) Learning Parameter Regions

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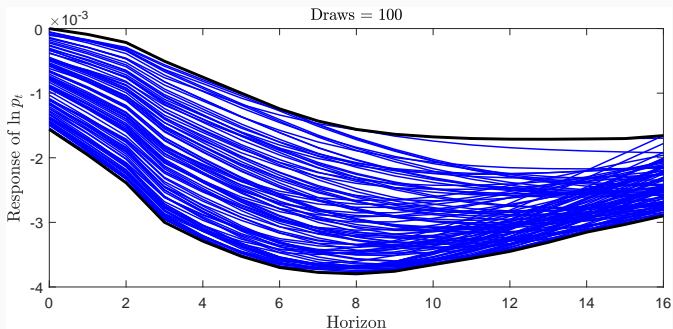
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# Introduction

- Recent gainful connection between Machine Learning & Econometrics
  - “Machine learning is a field that develops algorithms designed to be applied to datasets, with the main areas of focus being prediction (regression), classification, and clustering or grouping tasks” (Athey 2018)
- We use off-the-shelf ML concepts to study computational issues arising in some econometric models
- Motivating example is SVARs, but the scope is more general
  - reporting an estimator of an identified set
  - confidence set formed via inverting test statistics
  - highest posterior density credible set for a vector-valued parameter

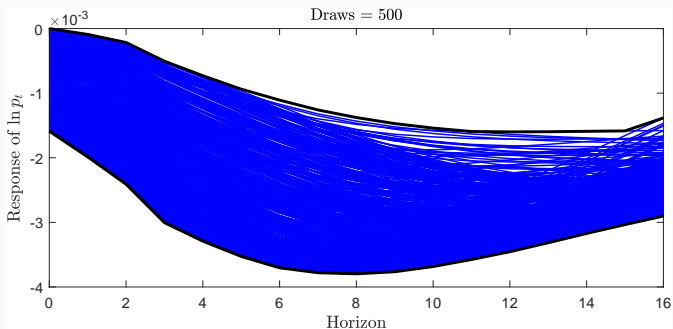
## A Motivating Example

- How does the price level respond to a monetary policy contraction?
- Model + US data + theory restrict responses to a set
- Difficult to describe this set analytically, so use 'random sampling' to generate an approximation



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- 'Random sampling approximations' are a 'supervised machine learning' problems
  - Analogous to sampling pixels of an image to recognize it
- This analogy allows us to
  1. Build a framework of 'learning' to discipline the way we think about the accuracy of a random sampling approximation
  2. Characterize what can and cannot be learned
  3. Provide concrete guidance on the number of random draws that suffice to guarantee we learn a parameter region

# Learning Framework

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## Abstract Definition of the Problem

- The parameters of interest are of the form  $\lambda(\theta) \in \mathbb{R}^d$ 
  - $\theta \in \mathbb{R}^p$ , parameters of a statistical model
  - $\lambda$  function of interest; e.g., IRFs, subvector, identity
- $\lambda(\theta)$  belongs to a set, denoted  $\lambda(S)$  - the parameter region of interest
  - $S \subseteq \mathbb{R}^p$
- Easy to check if  $\theta \in S$ : there is a labeling function  $l : l(\theta) = 1\{\theta \in S\}$
- Difficult to describe  $\lambda(S)$  analytically. All we know is  $\lambda(S) \in \Lambda$



## Sampling at Random: Supervised Learning Problem

- In order to evaluate  $\lambda(S)$ , use random sampling
  - Fix distribution  $P$ , generate i.i.d.  $(\theta_1, \dots, \theta_M)$
  - Use the draws and  $I(\cdot)$  to report some set  $\hat{\lambda}_M$
- In supervised learning terminology (Mohri 2012)
  - $(\lambda(\theta_1), \dots, \lambda(\theta_M))$  are *inputs*  $\sim$  i.i.d. according to  $P$
  - $(I(\theta_1), \dots, I(\theta_M))$  are binary *labels* generated by
$$I(\theta) = \mathbf{1}\{\theta \in S\}$$
  - $\hat{\lambda}_M$  is a *learning algorithm*: a map from inputs and labels to  $\Lambda$

## Learning Criterion

- Define misclassification error

$$\mathcal{L}(\hat{\lambda}_M; \lambda(S), P) \equiv P(\lambda(S) \Delta \hat{\lambda}_M),$$

$\Delta$  is the symmetric set difference

**DEFINITION 1:** A parameter region  $\lambda(S) \in \Lambda$  is said to be learnable if there exists an algorithm  $\hat{\lambda}_M$  and a number of draws  $m(\epsilon, \delta)$  such that for any  $\epsilon, \delta$ :

$$P(\mathcal{L}(\hat{\lambda}_M; \lambda, P) < \epsilon) \geq 1 - \delta,$$

for all  $P$  on  $\Theta$  and for any  $\lambda \in \Lambda$ ; provided  $M \geq m(\epsilon, \delta)$ .

Valiant, L.G. (1984): *A Theory of the Learnable*.

*PAC-Learning*.

- Suppose there exists a journal referee that can compute misclassification events:

$$\lambda \in \lambda(S) \Delta \hat{\lambda}_M$$

- The journal referee can  $P$ -compute how often misclassification happens:

$$\mathcal{L}(\hat{\lambda}_M; \lambda(S), P) \equiv P(\lambda(S) \Delta \hat{\lambda}_M),$$

- An approximation is  $\epsilon$ -good when

$$\mathcal{L}(\hat{\lambda}_M; \lambda(S), P) < \epsilon$$

- The journal referee is worried
  1. That due to a insufficient number of draws, the quality of approximation may be poor too often
  2. About the distribution the econometrician uses
- To protect against this, the oracle requires

$$P\left(\mathcal{L}(\hat{\lambda}_M; \lambda(S), P) < \epsilon\right) \geq 1 - \delta$$

Uniformly over all probability distributions and shapes of  $\lambda(S)$ .

# What Can and Cannot be Learned

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## Learning $\iff$ VC Dimension of $\Lambda$ is Finite

- **THEOREM 1:**  $\lambda(S) \in \Lambda$  is learnable  $\iff$   $\text{VC-dim}(\Lambda) < \infty$ .

PROOF: Blumer, Ehrenfeucht, Haussler, Warmuth (1989), *Learnability and the VC dimension*; Theorem 2.1

VC dimension

- Assumptions to simplify econometric problems insufficient to learn (via random sampling)
  - Convex sets have infinite VC dimension  $\implies$  cannot be learned
- If  $\lambda(S)$  can't live in too complex of a class: what can we learn?

## 'Tightest Bands' for Parameter Regions

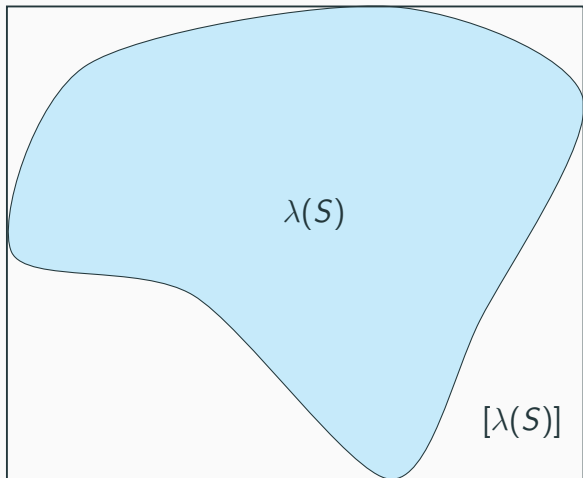
- Define the 'tightest band' containing  $\lambda(S)$  as follows:

$$[\lambda(S)] \equiv \prod_{j=1}^d \left[ \inf_{\theta \in S} \lambda_j(\theta), \sup_{\theta \in S} \lambda_j(\theta) \right]$$

( $\lambda_j$  is the  $j^{\text{th}}$  coordinate of  $\lambda \in \mathbb{R}^d$  )

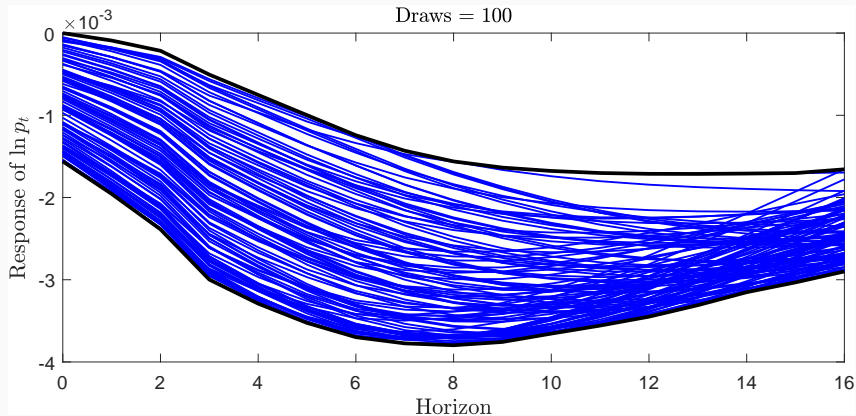
- The tightest band is a  $d$ -dimensional axis-aligned hyperrectangle, which has VC dimension of  $2d$

## Tightest Bands that Contains $\lambda(S)$





# Impulse Responses as Hyperrectangles



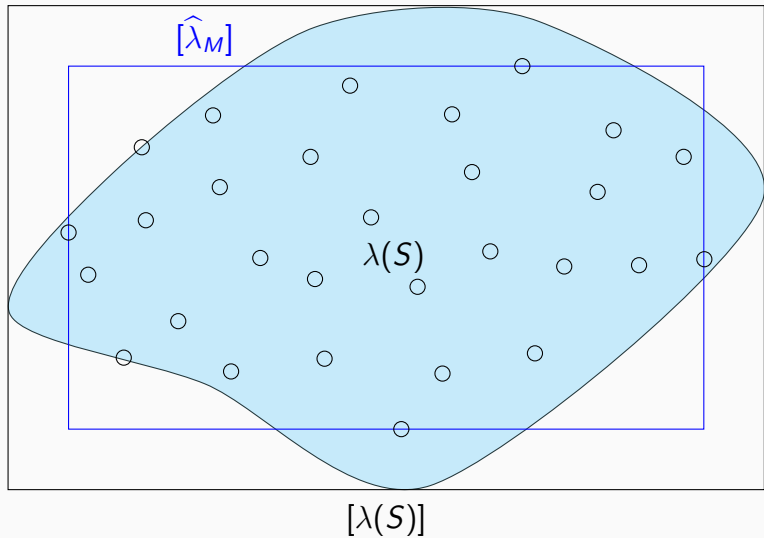
**DEFINITION 2:** Given a sample  $\boldsymbol{\theta}_M \equiv (\theta_1, \dots, \theta_M)$  with labels  $\mathbf{I}_M \equiv (I(\theta_1), \dots, I(\theta_M))$ , let  $[\widehat{\lambda}_M]$  denote the algorithm that reports

$$[\widehat{\lambda}_M](\boldsymbol{\theta}_M, \mathbf{I}_M) := \times_{j=1}^d \left[ \min_{m|I(\theta_m)=1} \lambda_j(\theta_m), \max_{m|I(\theta_m)=1} \lambda_j(\theta_m) \right]$$

where  $\lambda_j(\theta)$  is the  $j$ -th element of  $\lambda(\theta)$ .

- Report min. and max. in each dimension (over positive labels).

## Algorithm for Learning Bands



## Can we Learn $[\lambda(S)]$ using $[\hat{\lambda}_M]$ ?

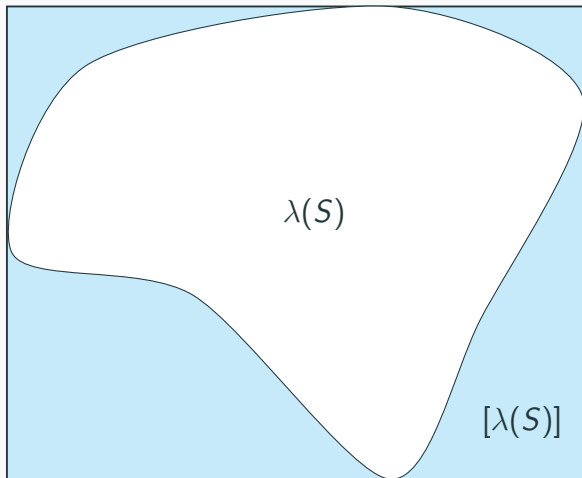
- Is there a number of draws  $m(\epsilon, \delta)$  such that

$$P\left(\mathcal{L}([\hat{\lambda}_M]; [\lambda], P) < \epsilon\right) \geq 1 - \delta$$

for any  $P$  on  $\Theta$ , for any  $\lambda \in \Lambda$ , when  $M > m(\epsilon, \delta)$ ?

- Theorem 2 in the paper answers this question in the negative ( $\nexists$  algorithm that returns  $\emptyset$  absent positive labels, and learns)
- Problem: allow for  $P$ 's that put high mass on  $[\lambda(S)] \setminus \lambda(S)$

Can we Learn  $[\lambda(S)]$  using  $[\hat{\lambda}_M]$ ?



- Define

$$\mathcal{P}(S) \equiv \{P \mid P \text{ is a distribution on } \Theta \text{ and } P(S) = 1\}$$

**DEFINITION 3:** The set  $[\lambda(S)]$  is said to be learnable **from the inside** if there exists an algorithm  $\hat{\lambda}_M$  and a number of draws  $m(\epsilon, \delta)$  such that

$$P \left( \mathcal{L}(\hat{\lambda}_M; [\lambda], P) < \epsilon \right) \geq 1 - \delta,$$

for any  $P \in \mathcal{P}(S)$  and any  $\lambda \in \Lambda$ , provided  $M \geq m(\epsilon, \delta)$ .

# How Many Draws to Learn from the Inside?

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**THEOREM 3:** The algorithm  $[\hat{\lambda}_M]$  learns  $[\lambda(S)]$  from the inside. Moreover, the ‘sample complexity’ of  $[\hat{\lambda}_M]$ —denoted  $m^*(\epsilon, \delta)$ —admits the following bounds:

$$(1 - \epsilon/\epsilon) \ln(1/\delta) \leq m^*(\epsilon, \delta) \leq (2d/\epsilon) \ln(2d/\delta)$$

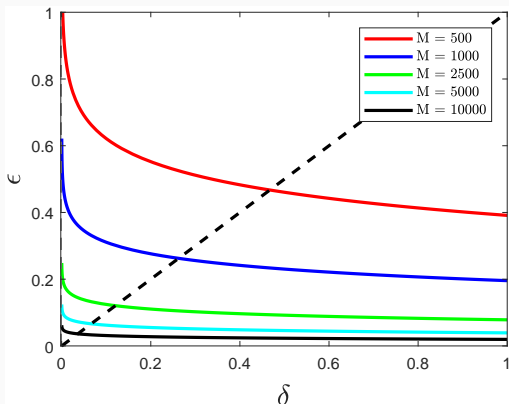
Proof

- For example  $\epsilon = \delta = 0.01$ ,  $d = 25$ 
  - Lower bound = 456
  - Upper bound = 42,586



## Iso-Draw Curves

- If choosing  $\epsilon$ - $\delta$  is a problem, commit to number of draws and report “Iso-Draw curves”
  - All the  $\epsilon$ - $\delta$  that support upper bound on sample complexity



## Example (Revisited)

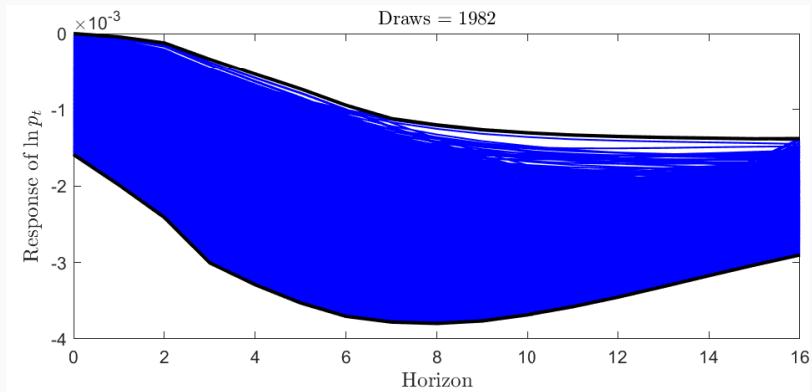
$$d = 17 \text{ (impact + 16 quarters)}$$

$$\epsilon = \delta = 0.1$$

Numbers of draws from inside sufficient for learning:

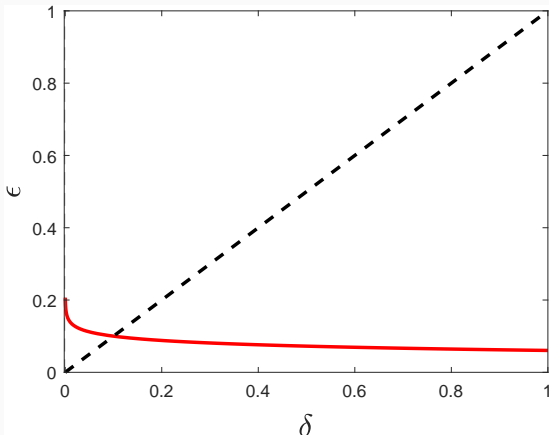
$$\frac{2d}{\epsilon} \log \left( \frac{2d}{\delta} \right) = 1,982$$

## Example (Revisited)



Misclassification error of less than 10% with probability at least 90%

## Example (Revisited)



Iso-draw curve: The values of  $\epsilon$ - $\delta$  that can be supported with 1,982 draws.

## Conclusion

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- Random sampling approximations are supervised learning problems
- Misclassification error and learning are natural criterion to judge the accuracy of these approximations
- Learning a parameter region is possible iff the class is not too complex
- Defined learning from the inside and showed that to learn the tightest bands from the inside  $(2d/\epsilon) \ln(2d/\delta)$  draws suffice

Thank you for listening!

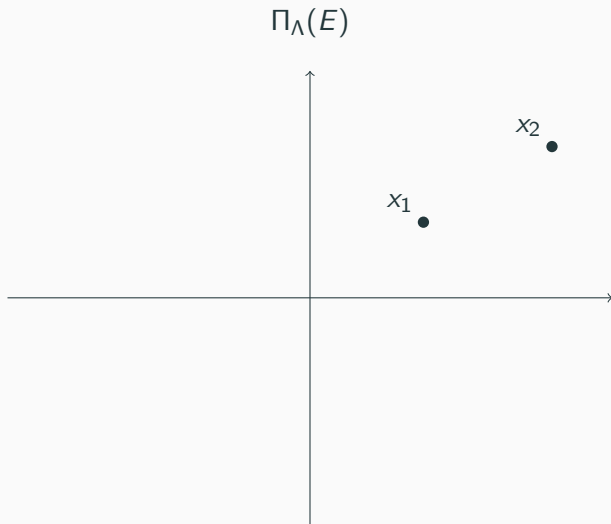
# VC Dimension

- Let  $E$  denote a finite subset of  $\mathbb{R}^d$  (the space in which  $\mathbf{\Lambda}$  lives)
- Define  $\Pi_{\mathbf{\Lambda}}(E) \equiv \{E \cap \Lambda \mid \Lambda \in \mathbf{\Lambda}\}$
- Say that  $E$  is *shattered* by the class  $\mathbf{\Lambda}$  whenever  $\Pi_{\mathbf{\Lambda}}(E) = 2^E$
- Define the VC dimension of  $\mathbf{\Lambda}$  as the cardinality of the largest finite set of points  $E$  shattered by the class  $\mathbf{\Lambda}$
- Vapnik, V. (1998): *Statistical Learning Theory*
- Axis-aligned rectangles have a VC dimension of 4

Back

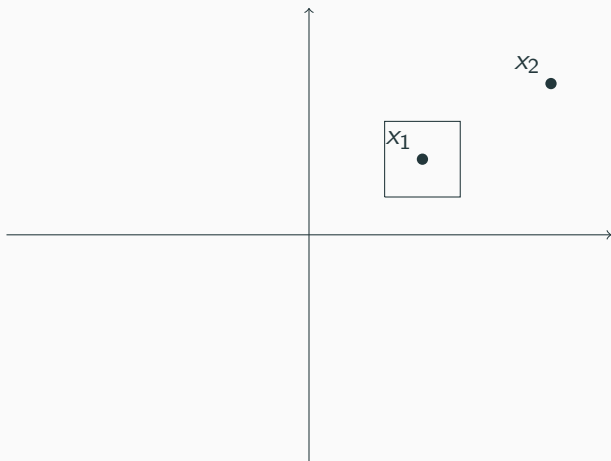


$E = \{x_1, x_2\}$ ;  $\Lambda$  : All axis-aligned rectangles



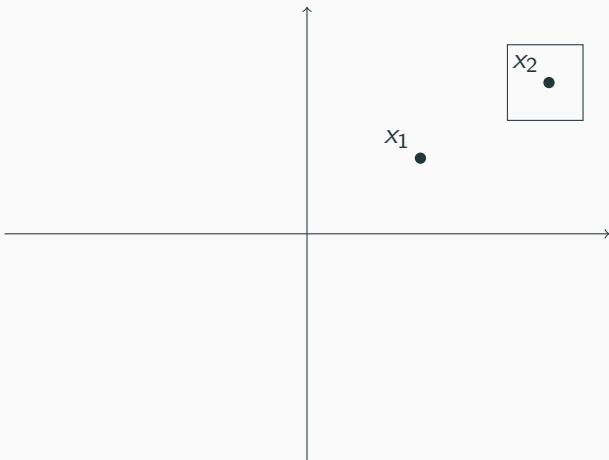
$E = \{x_1, x_2\}$ ;  $\Lambda$  : All axis-aligned rectangles

$$E \cap \Lambda = \{x_1\}$$



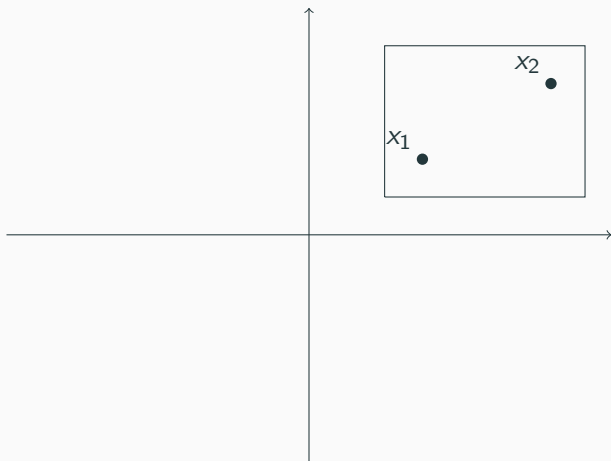
$E = \{x_1, x_2\}$ ;  $\Lambda$  : All axis-aligned rectangles

$$E \cap \Lambda = \{x_2\}$$



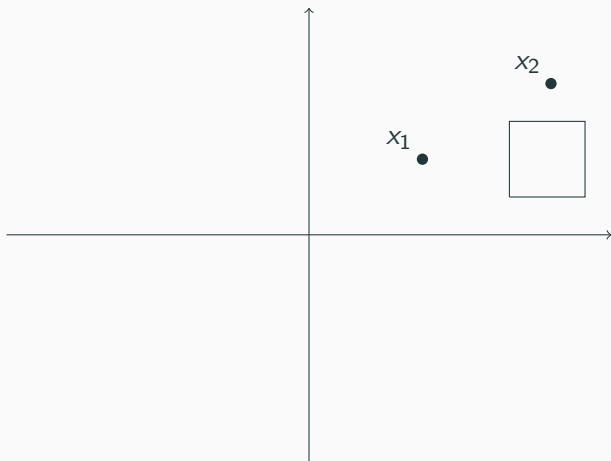
$E = \{x_1, x_2\}$ ;  $\Lambda$  : All axis-aligned rectangles

$$E \cap \Lambda = \{x_1, x_2\}$$



$E = \{x_1, x_2\}$ ;  $\Lambda$  : All axis-aligned rectangles

$$E \cap \Lambda = \{\emptyset\}$$



$$\Pi_{\Lambda}(E) = \{\{x_1\}, \{x_2\}, \{x_1, x_2\}, \{\emptyset\}\}$$

$$\text{VC-dim } \Lambda \geq 2$$

(In fact  $\text{VC-dim } \Lambda = 4$ )

Back

## Proof of Theorem 3

- The true concept is  $[\lambda(S)]$  and the estimator is  $[\hat{\lambda}_M]$
- Note that for any draws we have that  $[\hat{\lambda}_M] \subseteq [\lambda(S)]$ . Consequently:

$$\mathcal{L}([\hat{\lambda}_M]; [\lambda(S)], P) = P(\theta \in [\lambda(S)] \setminus [\hat{\lambda}_M])$$

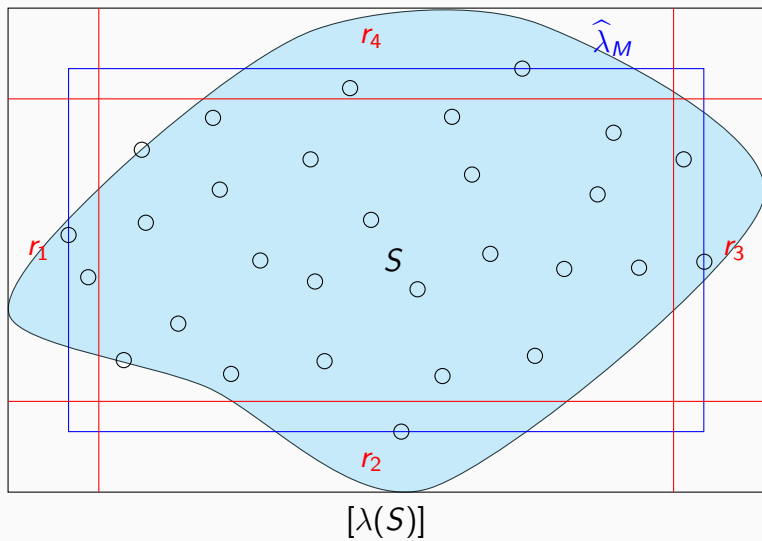
- Since  $P$  samples from inside  $S$ , then  $P(\lambda(\theta) \in [\lambda(S)]) = 1$ .
- Construct  $2d$  'special hyperrectangles'  $(r_1, r_2, \dots, r_{2d})$ , parallel to each side of  $[\lambda(S)]$ , each with probability  $\geq \epsilon/2d$  (but interior has probability  $\leq \epsilon/2d$ )

## Proof of Theorem 3

- Consider the event that  $[\hat{\lambda}_M]$  intersects each of these  $2d$  special rectangles
- The misclassification error is less than the probability of the union of the interior of these rectangles

$$\mathcal{L}([\hat{\lambda}_M]; [\lambda(S)], P) \leq \sum_{j=1}^{2d} \epsilon/2d = \epsilon$$





## Proof of Theorem 3

$$\begin{aligned} P(\mathcal{L}([\hat{\lambda}_M]; [\lambda(S)], P) > \epsilon) &\leq P([\hat{\lambda}_M] \cap r_j = \emptyset, \text{ for some } j) \\ &\leq \sum_{j=1}^{2d} P([\hat{\lambda}_M] \cap r_j = \emptyset) \\ &= \sum_{j=1}^{2d} P(\lambda(\theta_m) \notin r_j \text{ or } \theta_m \notin S)^M \\ &\leq \sum_{j=1}^{2d} P(\lambda(\theta_m) \notin r_j)^M \\ &\leq 2d(1 - \epsilon/2d)^M \end{aligned}$$

## Proof of Theorem 3

Learning is guaranteed whenever

$$2d(1 - \epsilon/2d)^M \leq \delta$$

$$\iff$$

$$M \geq -\ln(2d/\delta)/\ln(1 - \epsilon/2d)$$

Roughly

$$M \geq \frac{2d}{\epsilon} \ln\left(\frac{2d}{\delta}\right)$$